

<b>Notice of References Cited</b>	Application/Control No. 10/711,916	Applicant(s)/Patent Under Reexamination CHEN ET AL.	
	Examiner Ryan C. Jager	Art Unit 2816	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,198,340	03-2001	Ting et al.	327/536
*	B	US-6,100,557	08-2000	Hung et al.	257/299
*	C	US-5,909,141	06-1999	Tomishima, Shigeki	327/536
*	D	US-6,456,154	09-2002	Sugimura, Naoaki	327/537
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.